## Search Notes



Application/Control No.

Applicant(s)/Patent under Reexamination
LIAW ET AL.

09/709,759 Examiner Dustin Nguyen

Art Unit 2154

	SEAR	CHED	
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Class	Subclass	Date	Examiner
710	38, 64, 51, 73	3/26/2007	DN
709	219	3/26/2007	DN
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Class	Subclass	Date	Examine
710	38, 51	3/26/2007	DN
710	64, 73	3/26/2007	DN
709	218, 219	3/26/2007	DN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Jpdated EAST search, IEEE, ACM and google	3/26/2007	DN		
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